

## **Search Notes**



**Application/Control No.**

10/561,625

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Examiner

Chun Cao

**Applicant(s)/Patent under  
Reexamination**

TERECHKO ET AL.

## **Art Unit**

2115

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**